Application/Control No. Applicant(s)/Patent Under Reexamination 10/631,818 LIN, JEN CHIEN Notice of References Cited Examiner Art Unit Page 1 of 1 Jinhee J. Lee 2831 **U.S. PATENT DOCUMENTS** Date Document Number Classification Name Country Code-Number-Kind Code MM-YYYY US-6,733,333 B1 05-2004 Chen, Wilson 439/552 Α US-5,797,771 08-1998 Garside, R. Troy 439/610 В US-C US-D US-Ε US-F G US-US-Н US-US-US-Κ US-L US-Μ FOREIGN PATENT DOCUMENTS **Document Number** Date Country Country Code-Number-Kind Code Name Classification MM-YYYY Ν 0 Р Q R s T **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U

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